


Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/809,422		TAYU ET AL.	
	Examiner		Art Unit	
	John P. Sheehan		1742	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
148		301		148	302	101	102	103	
INTERNATIONAL CLASSIFICATION				75	232	233	234	244	246
H01F	1	053	419	12	20				
H01F	1	057							
					Total Claims Allowed: 17				
(Assistant Examiner) (Date) GL 06/09/05 (Legal Instruments Examiner) (Date)					(Primary Examiner) (Date) John P. Sheehan 6/6/05				
					O.G. Print Claim(s) 1		O.G. Print Fig. 1		

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input checked="" type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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